

<p>Based on Form PTO-1449 (3/90)</p> <p>LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)</p> <p><i>O I P E J C I</i> FEB 06 2004 PATENT & TRADEMARK OFFICE</p>				ATTY. DOCKET NO. 982020-2002.1	SERIAL NO. 10/660,127			
				APPLICANT Satoru YUKIE et al.				
				FILING DATE September 10, 2003		GROUP 2681		
				U.S. PATENT DOCUMENTS				
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
FOREIGN PATENT DOCUMENTS								
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
<i>AA</i>	AA	DE 10016622 A1	18-10-2001	GERMANY	H 04 B 7/005	—		X
<i>AB</i>	AB	EP 1032226 A1	30-08-2000	EUROPE	H 04 Q 7/26	—		X
<i>AC</i>	AC	EP 1158754 A2	28-11-2001	EUROPE	H 04 M 1/725	—	X	
<i>AD</i>	AD	EP 1158754 A3	12-11-2003	EUROPE	H 04 Q 1/725		X	
<i>AE</i>	AE	DE 19527815 C1	17-10-1996	GERMANY	H 04 M 3/42	—		X
<i>AF</i>	AF	EP 1137240 A2	26-09-2001	EUROPE	H 04 M 1/725	—		X
<i>AG</i>	AG	EP 1137240 A3	26-09-2001	EUROPE	H 04 M 1/725	—		X
<i>AH</i>	AH	DE 19833318 A1	03-02-2000	GERMANY	H 04 Q 7/20	—		X
<i>AI</i>	AI	WO 0207387 A1	24-01-2002	PCT	H 04 L 12/28	—	ABSTRACT ONLY	
<i>AJ</i>	AJ	JP 2000209657	28-07-2000	JAPAN	H04Q 7/38 G06F 3/00	—	ABSTRACT ONLY	
OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)								
	AK		PCT International Search Report for International Application No. PCT/US03/28589, corresponding to U.S. Patent Application No. 10/660,127					
EXAMINER <i>Sam Hanan</i>			DATE CONSIDERED 03/16/06					
<p>* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</p>								